Search Notes						

 Application/Control No.	Applicant(s)/Patent under Reexamination
10/757,073	YEH ET AL.
Examiner	Art Unit
 Tan T. Nguyen	2827

SEARCHED					
Class	Subclass	Date	Examiner		
-			:		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
365	185.19	11/22/2005	TNT		
365	185.22	11/22/2005	TNT		
365	185.28	11/22/2005	TNT		
365/185.29		11/22/2005	TNT		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
DATE	EXMR		
11/22/2005	TNT		
11/22/2005	TNT		
	DATE  11/22/2005		